### INTEGRATED CIRCUITS

# DATA SHEET

## PCX8582X-2 Family 256 x 8-bit CMOS EEPROMS with I<sup>2</sup>C-bus interface

Product specification Supersedes data of February 1992 File under Integrated Circuits, IC12 December 1994

## **Philips Semiconductors**



**PHILIPS** 

**■** 7110826 0086478 8T7 **■** 

### PCX8582X-2 Family

#### **FEATURES**

- Low power CMOS
  - maximum active current 2.0 mA
  - maximum standby current 10 μA (at 6.0 V), typical 4 μA
- Non-volatile storage of 2-Kbits organized as 256 x 8-bits
- Single supply with full operation down to 2.5 V
- · On-chip voltage multiplier
- Serial input/output I<sup>2</sup>C-bus
- · Write operations
  - byte write mode
  - 8-byte page write mode (minimizes total write time per byte)
- Read operations
  - sequential read
  - random read
- · Internal timer for writing (no external components)
- · Power-on reset
- · High reliability by using a redundant storage code
- Endurance
  - >500 k E/W-cycles at T<sub>amb</sub> = 22 °C
- 40 years non-volatile data retention time (typ.)
- · Pin and address compatible to
  - PCX8570, PCF8571, PCF8572 and PCF8581
  - PCX8494X-2, PCX8598X-2 -Family.



#### DESCRIPTION

The PCX8582X-2 is a 2-Kbit ( $256 \times 8$ -bit) floating gate electrically erasable programmable read only memory (EEPROM). By using an internal redundant storage code it is fault tolerant to single bit errors. This feature dramatically increases reliability compared to conventional EEPROM memories.

Power consumption is low due to the full CMOS technology used. The programming voltage is generated on-chip, using a voltage multiplier.

As data bytes are received and transmitted via the serial I<sup>2</sup>C-bus, a package using eight pins is sufficient. Up to eight PCX8582X-2 devices may be connected to the I<sup>2</sup>C-bus. Chip select is accomplished by three address inputs (A0, A1, A2).

Timing of the ERASE/WRITE cycle is carried out internally, thus no external components are required. Pin 7 (PTC) must be connected to either V<sub>DD</sub> or left open-circuit.

There is an option of using an external clock for timing the length of an ERASE/WRITE cycle.

#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DD}$	supply voltage		2.5	6.0	V
I <sub>DDR</sub>	supply current READ	f <sub>SCL</sub> = 100 kHz			
		$V_{DD} = 3 V$	-	60	μΑ
		$V_{DD} = 6 V$		200	μΑ
I <sub>DDW</sub>	supply current ERASE/WRITE	f <sub>SCL</sub> = 100 kHz			
		$V_{DD} = 3 V$	_	0.6	mA
		$V_{DD} = 6 V$	_	2.0	mA
I <sub>DDSB</sub>	supply current STANDBY	V <sub>DD</sub> = 3 V	-	3.5	μА
		$V_{DD} = 6 V$	_	10	μА

December 1994

PCX8582X-2 Family

#### ORDERING INFORMATION

TYPE NUMBER		PACKAGE		TEMPERATURE (°C) SUPPLY (			PLY (V)
	NAME	DESCRIPTION	VERSION	MIN.	MAX.	MIN.	MAX.
PCF8582C-2P	DIP8	plastic dual in-line package;	SOT97-1	-40	+85	2.5	6.0
PCD8582D-2P		8 leads (300 mil)		-25	+70	3.0	6.0
PCF8582E-2P				-40	+85	4.5	5.5
PCA8582F-2P				-40	+125	4.5	5.5
PCF8582C-2T	SO8	plastic small outline	SOT96-1	-40	+85	2.5	6.0
PCD8582D-2T		package;		-25	+70	3.0	6.0
PCF8582E-2T		8 leads; body width 3.9 mm		-40	+85	4.5	5.5
PCA8582F-2T				-40	+125	4.5	5.5

#### **DEVICE SELECTION**

Table 1 Device selection code

SELECTION	DEVICE CODE			С	HIP ENABL	.E	R/W	
Bit	b71	b6	b5	b4	b3	b2	b1	b0
Device	1	0	1	0	A2	A1	A0	R/W

#### Note

1. The MSB b7 is sent first.

Table 2 Endurance and data retention guarantees

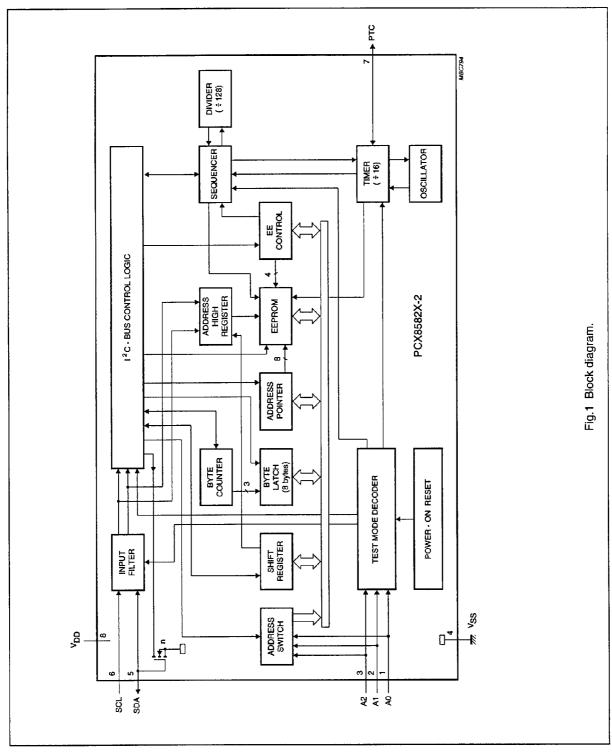
DEVICE	ENDURANCE E/W CYCLES	DATA RETENTION YEARS
PCF8582C-2; PCA8582F-2	500 000 <sup>(1)</sup>	40

### Note

1. At the time of publication of this data sheet the statistical history was not yet sufficient to guarantee 1000000000 E/W cycle performance for these types.

## PCX8582X-2 Family

### **BLOCK DIAGRAM**



December 1994

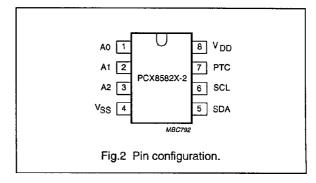
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## PCX8582X-2 Family

### **PINNING**

SYMBOL	PIN	DESCRIPTION
A0	1	address input 0
A1	2	address input 1
A2	3	address input 2
V <sub>SS</sub>	4	negative supply voltage
SDA	5	serial data input/output (I <sup>2</sup> C-bus)
SCL	6	serial clock input (I <sup>2</sup> C-bus)
PTC	7	programming time control output
$V_{DD}$	8	positive supply voltage



### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DD}$	supply voltage		-0.3	+7.0	V
VI	voltage on any input pin	$ Z_i  > 500 \Omega$	V <sub>SS</sub> - 0.8	$V_{DD} + 0.8$	V
lı	current on any input pin		_	1	mA
lo	output current		-	10	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>amb</sub>	operating ambient temperature				
	PCF8582C-2; PCF8582E-2		-40	+85	°C
	PCD8582D-2		-25	+70	°C
	PCA8582F-2		<b>-40</b>	+125	°C

### PCX8582X-2 Family

### **CHARACTERISTICS**

PCF8582C-2:  $V_{DD}$  = 2.5 to 6.0 V;  $V_{SS}$  = 0 V;  $T_{amb}$  = -40 to +85 °C; unless otherwise specified. PCD8582D-2:  $V_{DD}$  = 3.0 to 6.0 V;  $V_{SS}$  = 0 V;  $T_{amb}$  = -25 to +70 °C; unless otherwise specified. PCF8582E-2:  $V_{DD}$  = 4.5 to 5.5 V;  $V_{SS}$  = 0 V;  $T_{amb}$  = -40 to +85 °C; unless otherwise specified. PCA8582F-2:  $V_{DD}$  = 4.5 to 5.5 V;  $V_{SS}$  = 0 V;  $T_{amb}$  = -40 to +125 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Supplies			•		•
V <sub>DD</sub>	supply voltage				
	PCF8582C-2		2.5	6.0	ν
	PCD8582D-2		3.0	6.0	٧
	PCF8582E-2; PCA8582F-2		4.5	5.5	٧
I <sub>DDR</sub>	supply current READ	f <sub>SCL</sub> = 100 kHz			
	PCF8582C-2; PCD8582D-2	$V_{DD} = 3.0 \text{ V}$	-	60	μΑ
		$V_{DD} = 6.0 \text{ V}$	-	200	μΑ
	PCF8582E-2; PCA8582F-2	$V_{DD} = 5.5 \text{ V}$	-	200	μΑ
I <sub>DDW</sub>	supply current ERASE/WRITE	f <sub>SCL</sub> = 100 kHz			
	PCF8582C-2; PCD8582D-2	$V_{DD} = 3.0 \text{ V}$	_	0.6	mA
		$V_{DD} = 6.0 \text{ V}$	_	2.0	mA
	PCF8582E-2; PCA8582F-2	V <sub>DD</sub> = 5.5 V	_	2.0	mA
IDDSB	supply current STANDBY	f <sub>SCL</sub> = 100 kHz	· · · · · · · · · · · · · · · · · · ·		
5555	PCF8582C-2; PCD8582D-2	$V_{DD} = 3.0 \text{ V}$	-	3.5	μΑ
	·	$V_{DD} = 6.0 \text{ V}$	-	10	μΑ
	PCF8582E-2; PCA8582F-2	$V_{DD} = 5.5 \text{ V}$	_	10	μΑ
PTC input	(pin 7)				
$V_{IL}$	LOW level input voltage		-0.8	0.1V <sub>DD</sub>	٧
V <sub>IH</sub>	HIGH level input voltage		0.9V <sub>DD</sub>	$V_{DD} + 0.8$	٧
SCL input	(pin 6)				
V <sub>IL</sub>	LOW level input voltage		-0.8	0.3V <sub>DD</sub>	V
$V_{iH}$	HIGH level input voltage		0.7V <sub>DD</sub>	$V_{DD} + 0.8$	٧
ILI	input leakage current	$V_I = V_{DD}$ or $V_{SS}$	-	±1	μА
f <sub>SCL</sub>	clock input frequency		0	100	kHz
Cı	input capacitance	V <sub>I</sub> = V <sub>SS</sub>		7	pF
SDA input	/output (pin 5)				
V <sub>IL</sub>	LOW level input voltage		-0.8	0.3V <sub>DD</sub>	٧
V <sub>IH</sub>	HIGH level input voltage		0.7V <sub>DD</sub>	$V_{DD} + 0.8$	٧
V <sub>OL</sub>	LOW level output voltage	$I_{OL} = 3 \text{ mA}; V_{DD(min)}$	-	0.4	٧
lLO	output leakage current	$V_{OH} = V_{DD}$	-	1	μА
Cı	input capacitance	V <sub>I</sub> = V <sub>SS</sub>	_	7	pF
Data reten	tion time				
ts	data retention time	T <sub>amb</sub> = 55 °C	10	<b>—</b>	years

December 1994

6

## PCX8582X-2 Family

### WRITE CYCLE LIMITS

Selection of the chip address is achieved by connecting the A0, A1 and A2 inputs to either  $V_{SS}$  or  $V_{DD}$ .

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
ERASE/W	RITE cycle timing				1	
t <sub>E/W</sub>	ERASE/WRITE cycle time					
	internal oscillator		_	7	_	ms
	external clock		4	-	10	ms
Enduranc	e					
NEW	ERASE/WRITE cycle per byte					
	PCF8582C-2	T <sub>amb</sub> = 85 °C; t <sub>E/W</sub> = 4 to 10 ms	100000	_	_	cycles
		T <sub>amb</sub> = 22 °C; t <sub>E/W</sub> = 5 ms	500000	-	_	cycles
	PCD8582D-2	T <sub>amb</sub> = -25 to +70 °C; t <sub>E/W</sub> = 4 to 10 ms	10000	_	_	cycles
		$T_{amb} = -25 \text{ to } +40 \text{ °C; } t_{E/W} = 5 \text{ ms}$	100000	-	-	cycles
	PCF8582E-2	$T_{amb} = -40 \text{ to } +85 \text{ °C};$ $t_{E/W} = 4 \text{ to } 10 \text{ ms}$	10000	_	_	cycles
		T <sub>amb</sub> = 22 °C; t <sub>E/W</sub> = 5 ms	100000	-	-	cycles
	PCA8582F-2	T <sub>amb</sub> = 125 °C; t <sub>E/W</sub> = 4 to 10 ms	50000	-	-	cycles
		T <sub>amb</sub> = 85 °C; t <sub>E/W</sub> = 4 to 10 ms	100000	_	-	cycles
		T <sub>amb</sub> = 22 °C; t <sub>E/W</sub> = 5 ms	500000	_	_	cycles

### PCX8582X-2 Family

#### I<sup>2</sup>C-BUS PROTOCOL

The I<sup>2</sup>C-bus is for 2-way, 2-line communication between different ICs or modules. The serial bus consists of two bidirectional lines: one for data signals (SDA), and one for clock signals (SCL).

Both the SDA and SCL lines must be connected to a positive supply voltage via a pull-up resistor.

The following protocol has been defined:

- Data transfer may be initiated only when the bus is not busy.
- During data transfer, the data line must remain stable whenever the clock line is HIGH. Changes in the data line while the clock line is HIGH will be interpreted as control signals.

The following bus conditions have been defined:

- Bus not busy: both data and clock lines remain HIGH.
- Start data transfer: a change in the state of the data line, from HIGH-to-LOW, while the clock is HIGH, defines the start condition.
- Stop data transfer: a change in the state of the data line, from LOW-to-HIGH, while the clock is HIGH, defines the stop condition.
- Data valid: the state of the data line represents valid data when, after a start condition, the data line is stable for the duration of the HIGH period of the clock signal.
  There is one clock pulse per bit of data.

Each data transfer is initiated with a start condition and terminated with a stop condition; the number of the data bytes, transferred between the start and stop conditions is limited to seven bytes in the ERASE/WRITE mode and eight bytes in the PAGE ERASE/WRITE mode. Data transfer is unlimited in the READ mode. The information is transmitted in bytes and each receiver acknowledges with a ninth bit.

Within the I<sup>2</sup>C-bus specifications a low-speed mode (2 kHz clock rate) and a high speed mode (100 kHz clock rate) are defined.

The PCX8582X-2 operates in both modes.

By definition a device that sends a signal is called a 'transmitter', and the device which receives the signal is called a 'receive'. The device which controls the signal is called the 'master'. The devices that are controlled by the master are called 'slaves'.

Each byte is followed by one acknowledge bit. This acknowledge bit is a HIGH level, put on the bus by the transmitter. The master generates an extra acknowledge related clock pulse. The slave receiver which is addressed is obliged to generate an acknowledge after the reception of each byte.

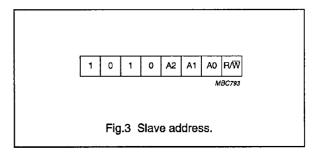
The master receiver must generate an acknowledge after the reception of each byte that has been clocked out of the slave transmitter.

The device that acknowledges has to pull down the SDA line during the acknowledge clock pulse in such a way that the SDA line is stable LOW during the HIGH period of the acknowledge related clock pulse.

Set-up and hold times must be taken into account. A master receiver must signal an end of data to the slave transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this event the transmitter must leave the data line HIGH to enable the master generation of the stop condition.

#### **DEVICE ADDRESSING**

Following a start condition the bus master must output the address of the slave it is accessing. The most significant four bits of the slave address are the device type identifier (see Fig.3). For the PCX8582X-2 this is fixed as 1010.



The next three significant bits address a particular device. A system could have up to eight PCX8582X-2 devices on the bus. The eight addresses are defined by the state of the A0, A1 and A2 inputs.

The last bit of the slave address defines the operation to be performed. When set to logic 1 a read operation is selected.

Address bits must be connected to either  $V_{DD}$  or  $V_{SS}$ .

December 1994

8

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### PCX8582X-2 Family

#### WRITE OPERATIONS

#### Byte/word write

For a write operation the PCX8582X-2 requires a second address field. This address field is a word address providing access to the 256 words of memory. Upon receipt of the word address the PCX8582X-2 responds with an acknowledge and awaits the next eight bits of data, again responding with an acknowledge. Word address is automatically incremented. The master can now terminate the transfer by generating a stop condition or transmit up to six more bytes of data and then terminate by generating a stop condition.

After this stop condition the ERASE/WRITE cycle starts and the bus is free for another transmission. Its duration is 7 ms (typ.) per byte.

During the ERASE/WRITE cycle the slave receiver does not send an acknowledge bit if addressed via the I<sup>2</sup>C-bus.

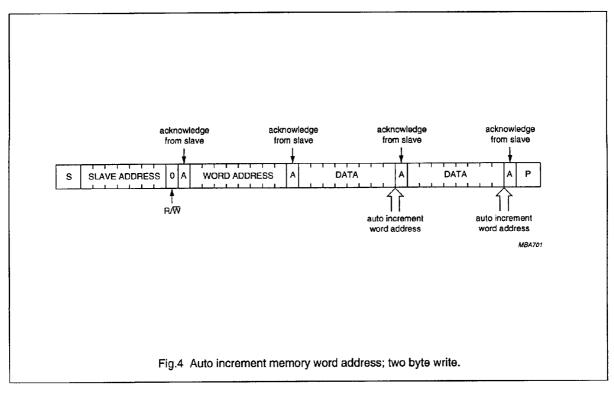
#### **PAGE WRITE**

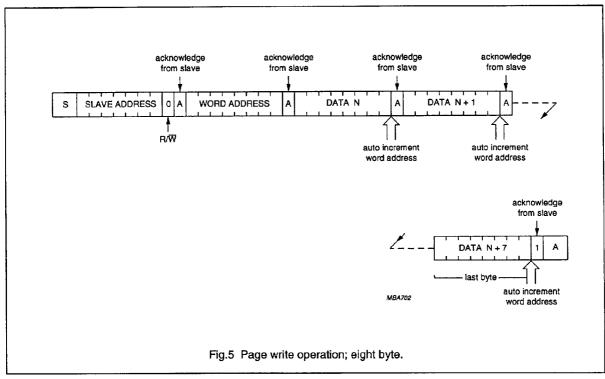
The PCX8582X-2 is capable of an eight-byte page write operation. It is initiated in the same manner as the byte write operation. The master can transmit eight data bytes within one transmission. After receipt of each byte the PCX8582X-2 will respond with an acknowledge. The typical ERASE/WRITE time in this mode is  $9 \times 7 \text{ ms} = 63 \text{ ms}$ .

After the receipt of each data byte the three low order bits of the word address are internally incremented. The high order five bits of the address remain unchanged. If the master transmits more than eight bytes prior to generating the stop condition, no acknowledge will be given on the ninth (and following) data bytes and the whole transmission will be ignored. As in the byte write operation, all inputs are disabled until completion of the internal write cycles.

December 1994

### PCX8582X-2 Family





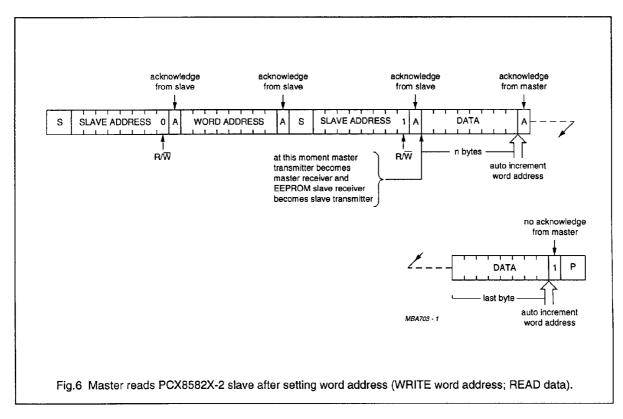
December 1994

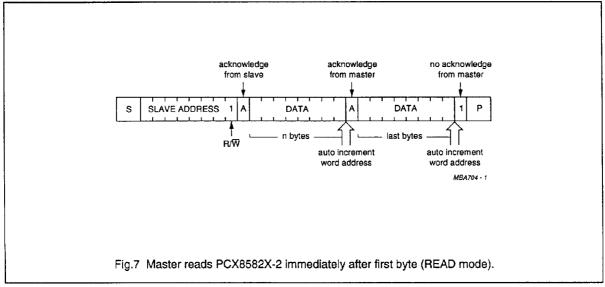
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### PCX8582X-2 Family

#### **READ OPERATIONS**

Read operations are initiated in the same manner as write operations with the exception that the LSB of the slave address is set to logic 1. There are three basic read operations; current address read, random read and sequential read.





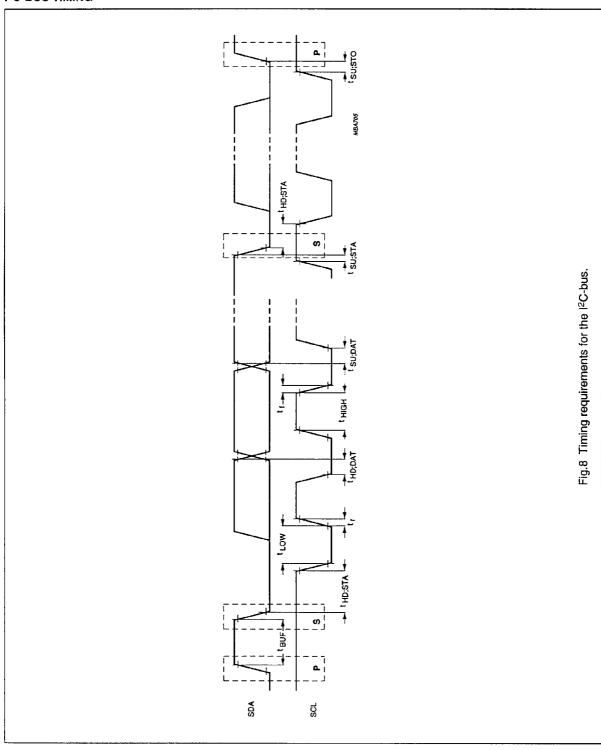
December 1994

11

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## PCX8582X-2 Family

### I<sup>2</sup>C-BUS TIMING



December 1994

12

### PCX8582X-2 Family

### I<sup>2</sup>C-BUS CHARACTERISTICS

All of the timing values are valid within the operating supply voltage and ambient temperature range and refer to  $V_{IL}$  and  $V_{IH}$  with an input voltage swing from  $V_{SS}$  to  $V_{DD}$ .

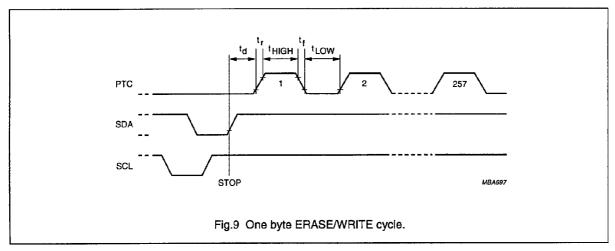
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
f <sub>SCL</sub>	clock frequency		0	100	kHz
t <sub>BUF</sub>	time the bus must be free before new transmission can start		4.7	_	μs
t <sub>HD;STA</sub>	start condition hold time after which first clock pulse is generated		4.0	-	μs
tLOW	LOW level clock period		4.7	_	μs
<sup>t</sup> ніGH	HIGH level clock period		4.0	-	μs
tsu;sta	set-up time for start condition	repeated start	4.7	-	μs
t <sub>HD;DAT</sub>	data hold time for bus compatible masters		5	-	μs
tho;dat	data hold time for bus devices	note 1	0	-	ns
tsu;dat	data set-up time		250	-	ns
t <sub>r</sub>	SDA and SCL rise time		-	1	μs
t <sub>f</sub>	SDA and SCL fall time		-	300	ns
t <sub>su;sто</sub>	set-up time for stop condition		4.7	-	μs

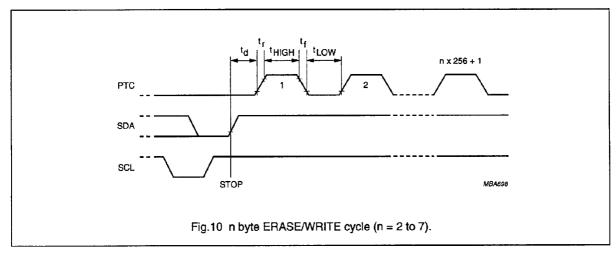
#### Note

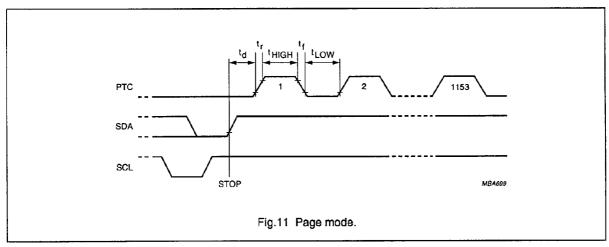
1. The hold time required (not greater than 300 ns) to bridge the undefined region of the falling edge of SCL must be internally provided by a transmitter.

### PCX8582X-2 Family

### **EXTERNAL CLOCK TIMING**





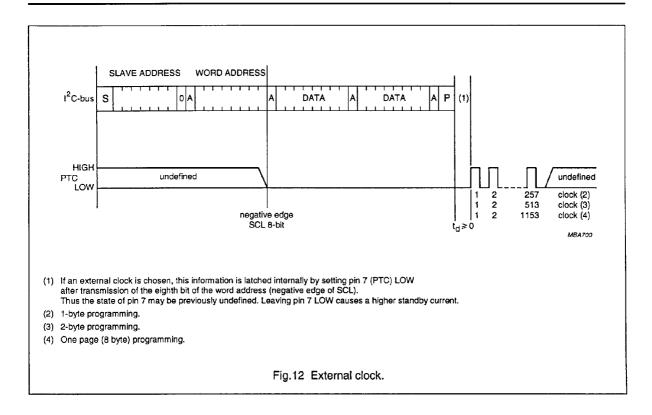


December 1994

14

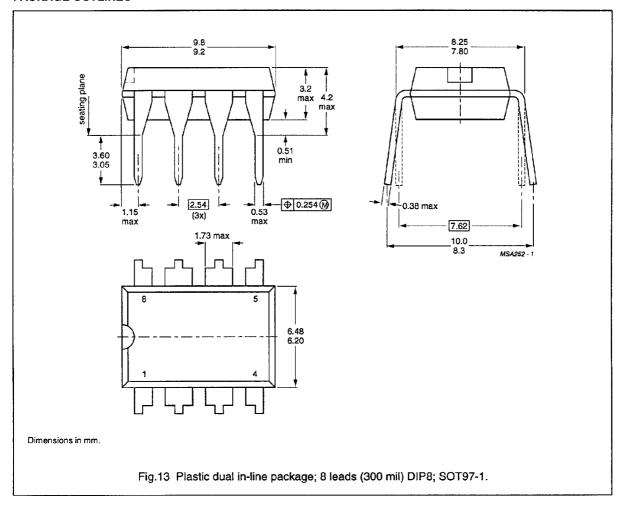
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### PCX8582X-2 Family

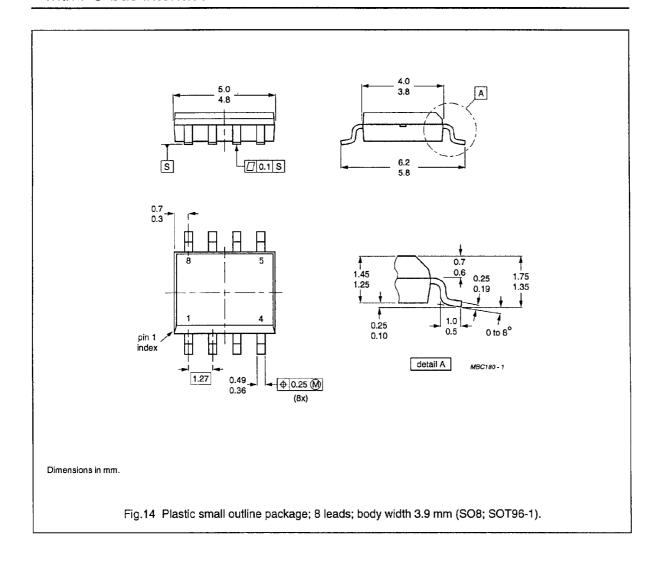


## PCX8582X-2 Family

### PACKAGE OUTLINES



## PCX8582X-2 Family



### PCX8582X-2 Family

#### **SOLDERING**

#### Plastic dual in-line packages

BY DIP OR WAVE

The maximum permissible temperature of the solder is 260 °C; this temperature must not be in contact with the joint for more than 5 s. The total contact time of successive solder waves must not exceed 5 s.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified storage maximum. If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

#### REPAIRING SOLDERED JOINTS

Apply a low-voltage soldering iron below the seating plane (or not more than 2 mm above it). If its temperature is below 300 °C, it must not be in contact for more than 10 s; if between 300 and 400 °C, for not more than 5 s.

#### Plastic small-outline packages

BY WAVE

During placement and before soldering, the component must be fixed with a droplet of adhesive. After curing the adhesive, the component can be soldered. The adhesive can be applied by screen printing, pin transfer or syringe dispensing.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder bath is 10 s, if allowed to cool to less than 150 °C within 6 s. Typical dwell time is 4 s at 250 °C.

A modified wave soldering technique is recommended using two solder waves (dual-wave), in which a turbulent wave with high upward pressure is followed by a smooth laminar wave. Using a mildly-activated flux eliminates the need for removal of corrosive residues in most applications.

#### By SOLDER PASTE REFLOW

Reflow soldering requires the solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the substrate by screen printing, stencilling or pressure-syringe dispensing before device placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt, infrared, and vapour-phase reflow. Dwell times vary between 50 and 300 s according to method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 min at 45  $^{\circ}$ C.

REPAIRING SOLDERED JOINTS (BY HAND-HELD SOLDERING IRON OR PULSE-HEATED SOLDER TOOL)

Fix the component by first soldering two, diagonally opposite, end pins. Apply the heating tool to the flat part of the pin only. Contact time must be limited to 10 s at up to 300 °C. When using proper tools, all other pins can be soldered in one operation within 2 to 5 s at between 270 and 320 °C. (Pulse-heated soldering is not recommended for SO packages.)

For pulse-heated solder tool (resistance) soldering of VSO packages, solder is applied to the substrate by dipping or by an extra thick tin/lead plating before package placement.

December 1994